

Crystal Clock Oscillator — TTL TRI-STATE

by SaRonix

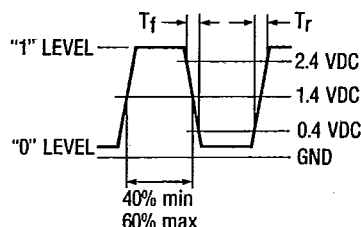
Technical Data

Ref. No. Series M
Date May 1988
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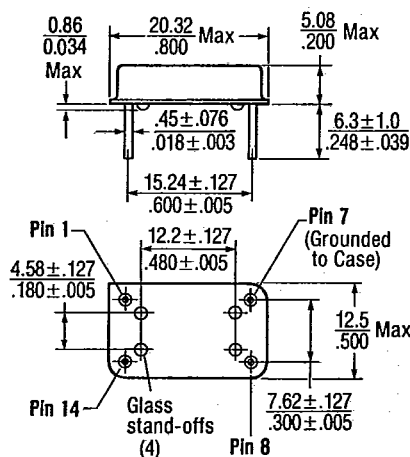
Description

A crystal controlled hybrid oscillator circuit providing TTL tri-state logic. The third state in tri-state logic is an open circuit. The internal circuitry is disconnected from the output allowing it to assume any logic level. Device is packaged in a 14-pin DIP compatible, resistance welded, all metal case. Pin 7 is grounded to the case to reduce RFI.

Output Waveform



Package



Pin 1: Tri-State Control Pin 7: GND
Pin 8: Output Pin 14: +5 VDC

Standard Marking Format



Scale: None (Dimension in $\frac{\text{mm}}{\text{inches}}$)

Frequency Range:

250 kHz to 50 MHz

Frequency Stability:

±0.0025% to ±0.10% over all conditions: calibration tolerance, operating temperature, input voltage change, load change, aging, shock and vibration.

Temperature Range:

Operating: 0°C to +70°C
Storage: -55°C to +125°C

Input Voltage:

+5VDC $\pm$ 10%

Input Current:

Current:	Maximum @ 25°C	Maximum over Temperature
250 kHz-3.9999 MHz:	40 mA	50 mA
4.0 MHz-20.0000 MHz:	35 mA	45 mA
20.0 + MHz-50.00 MHz:	50 mA	60 mA

Tri-State Output:

Symmetry: 50% $\pm$ 10% @ 1.4VDC level
Rise & Fall Times: (10 TTL loads):
8 ns max for 250 kHz to 20 MHz
6 ns max for over 20 MHz

"0" Level: +0.4 volts

"1" Level: +2.4 volts

Output Load: 1 to 10 TTL gates

* Tri-State Control-Pin 1: Logic "1" or no connection = RF out
Logic "0" or Ground = High Impedance

Mechanical:

Shock:	MIL-STD-883C, Method 2002.3, Condition B
Solderability:	MIL-STD-883C, Method 2003.5
Terminal Strength:	MIL-STD-202F, Method 211A, Conditions A and C
Vibration:	MIL-STD-883C, Method 2007.1, Condition A
Solvent Resistance:	MIL-STD-202F, Method 215C
Resistance to Soldering Heat:	MIL-STD-202F, Method 210A, Condition B

Environmental:

Gross Leak Test:	MIL-STD-883C, Method 1014.8, Condition C1
Fine Leak Test:	MIL-STD-883C, Method 1014.8, Condition A2, <5 × 10 ⁻⁸ ATM cc/sec.
Thermal Shock:	MIL-STD-883C, Method 1011.7, Condition A
Moisture Resistance:	MIL-STD-883C, Method 1004.6

Part Numbering Guide

NTT 050 C* - 6.0000

Type

Model

040—250 kHz—3.9999 MHz
050—4.0 MHz—20.0000 MHz
070—20+ MHz—50.000 MHz

- **Stability Tolerance:**

A = ± 25 ppm (0.0025%)
B = ± 50 ppm (0.0050%)
C = ± 100 ppm (0.0100%)
D = ± 500 ppm (0.0500%)
E = $\pm 1\,000$ ppm (0.1000%)

*For inverse logic state on pin #1, add "R" suffix after the tolerance.
Example: NTT050CR - 6.0000



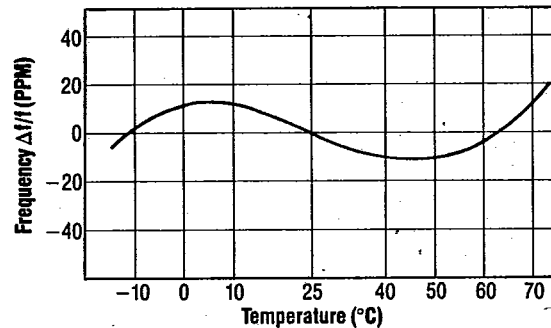
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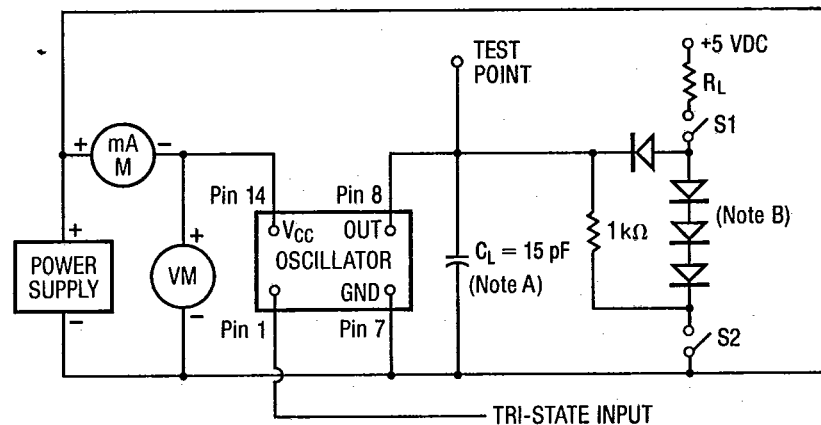
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Frequency and Temperature Characteristics



Test Circuit



NOTES: A. C_L includes probe and jig capacitance.
B. All diodes are 1N4148 or equivalent.

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